Notice of References Cited Application/Control No. 10/520,498 Examiner TAE K. KIM Applicant(s)/Patent Under Reexamination AHN ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0180579	12-2002	Nagaoka et al.	340/3.1
*	В	US-6,058,426	05-2000	Godwin et al.	709/229
*	С	US-5,758,057	05-1998	Baba et al.	714/7
*	D	US-5,949,977	09-1999	Hernandez, E. Norman	709/229
*	Е	US-5,987,021	11-1999	Erickson et al.	370/347
*	F	US-2002/0067717	06-2002	Raschke et al.	370/386
*	G	US-2004/0068756	04-2004	Chiu, Tom	725/135
*	Н	US-2005/0010816	01-2005	Yu et al.	713/201
	-	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	C					
	V					
	w					
	х					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.